

Application/Control No. 10/551.139

Examiner REI-TSANG SHIAO Applicant(s)/Patent under Reexamination BARTSCH ET AL. Art Unit

1626

				ISSUE	CL	.AS	SIF	ICAT	ION						
		ORIGINAL	-		INTERNATIONAL CLASSIFICATION										
CLASS			SUBCLASS		CLAIMED						NON-CLAIMED				
502			162		В	01	J	31	/00			1			
CROSS REFERENCES						07	F	9	/02			,			
CLASS	SUBCLA	SS (ONE S	SUBCLASS PE	R BLOCK)											
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(Assistant Examiner) (Date)

(Legal Instruments Examiner) (Date)

(Primary Examiner) (Date)

(233										1						NONE			
	Claims renumbered in the same order as presented by applicant									□СРА			☑ T.D.			☐ R.1.47			
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